

Notice of References Cited	Application/Control No. 10/624,678	Applicant(s)/Patent Under Reexamination SUGITA ET AL.	
	Examiner Rip A. Lee	Art Unit 1713	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,654,121 A	08-1997	Eichhorn et al.	430/157
	B	US-4,604,438	08-1986	Beuhler et al.	526/262
	C	US-4,373,046	02-1983	Hagiwara et al.	524/285
	D	US-4,093,678	06-1978	Bailey et al.	525/210
	E	US-2002/0086934 A1	07-2002	Kawaguchi et al.	524/544
	F	US-5,866,659 A	02-1999	Chung et al.	525/279
	G	US-5,629,393 A	05-1997	Varshney et al.	526/175
	H	US-4,569,963	02-1986	Hisaki et al.	524/458
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 6-161111	06-1994	Japan	Murata et al.	G03F 7/039
	O	JP 61-285233	12-1986	Japan	---	C08L 9/00
	P	JP 58-38711	03-1983	Japan	---	C08F 291/00
	Q	JP 57-135818	08-1982	Japan	---	C08F 255/02
	R	JP 56-122862	09-1981	Japan	---	C08L 101/00
	S	JP 3-100005	04-1991	Japan	---	C08F 32/08
	T	JP 2002-3543	01-2002	Japan	----	C08F 232/08

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Carpino, L.A.; Goewecke, S. J. Org. Chem. 1964, 29, 2824-30 (abstract only)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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